

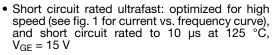
IGBT SIP Module (Short Circuit Rated Ultrafast IGBT)



IMS-2

PRODUCT SUMMARY					
OUTPUT CURRENT IN A TYPICAL 20 kHz MOTOR DRIVE					
V _{CES} 600 V					
I _{RMS} per phase (1.94 kW total) with T _C = 90 °C	6.7 A _{RMS}				
TJ	125 °C				
Supply voltage	360 V _{DC}				
Power factor	0.8				
Modulation depth (see fig. 1)	115 %				
V _{CE(on)} (typical) at I _C = 6.0 A, 25 °C	1.72 V				
Speed	8 kHz to 30 kHz				
Package	SIP				
Circuit	Three phase inverter				

FEATURES





ROHS

- Fully isolated printed circuit board mount package
- Switching-loss rating includes all "tail" losses
- HEXFRED® soft ultrafast diodes
- UL approved file E78996
- · Designed and qualified for industrial level
- Material categorization: for definitions of compliance please see <u>www.vishav.com/doc?99912</u>

DESCRIPTION

The IGBT technology is the key to Vishay's Semiconductors advanced line of IMS (Insulated Metal Substrate) power modules. These modules are more efficient than comparable bipolar transistor modules, while at the same time having the simpler gate-drive requirements of the familiar power MOSFET. This superior technology has now been coupled to a state of the art materials system that maximizes power throughput with low thermal resistance. This package is highly suited to motor drive applications and where space is at a premium.

PARAMETER SY		TEST CONDITIONS	MAX.	UNITS	
Collector to emitter voltage	V _{CES}		600	V	
Continuous collector current, each IGBT	I _C	T _C = 25 °C	11 A		
		T _C = 100 °C	6.0	A	
Pulsed collector current	Ісм	Repetitive rating; $V_{GE} = 20 \text{ V}$, pulse width limited by maximum junction temperature See fig. 20	22	А	
Clamped inductive load current	I _{LM}	V_{CC} = 80 % (V_{CES}), V_{GE} = 20 V, L = 10 μ H, R_G = 22 Ω See fig. 19	22	А	
Diode continuous forward current	I _F	T _C = 100 °C	6.1	Α	
Diode maximum forward current	I _{FM}		22	А	
Short circuit withstand time	t _{SC}		10	μs	
Gate to emitter voltage	V_{GE}		± 20	V	
Isolation voltage	V _{ISOL}	Any terminal to case, t = 1 minute	2500	V _{RMS}	
	P _D	T _C = 25 °C	36	W	
Maximum power dissipation, each IGBT		T _C = 100 °C	14		
Operating junction and storage temperature range	T _J , T _{Stg}		-40 to +150	°C	
Soldering temperature		For 10 s, (0.063" (1.6 mm) from case)	300	1	
Mounting torque		6-32 or M3 screw	5 to 7 (0.55 to 0.8)	lbf · in (N · m)	





THERMAL AND MECHANICAL SPECIFICATIONS						
PARAMETER	SYMBOL	TYP.	MAX.	UNITS		
Junction to case, each IGBT, one IGBT in conduction	R _{thJC} (IGBT)	=	3.5			
Junction to case, each DIODE, one DIODE in conduction	R _{thJC} (DIODE)	-	5.5	°C/W		
Case to sink, flat, greased surface	R _{thCS} (MODULE)	0.10	-			
Woight of modulo		20	- 1	g		
Weight of module		0.7	-	OZ.		

ELECTRICAL SPECIFICATIONS (T _J = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNITS
Collector to emitter breakdown voltage	V _{(BR)CES} (1)	$V_{GE} = 0 \text{ V}, I_{C} = 250 \mu\text{A}$		600	-	-	V
Temperature coeff. of breakdown voltage	$\Delta V_{(BR)CES}/\Delta T_J$	$V_{GE} = 0 \text{ V}, I_{C} = 1.0 \text{ mA}$		1	0.45	-	V/°C
		I _C = 6.0 A		-	1.72	2.10	V
Collector to emitter saturation voltage	V05()	I _C = 11 A	V _{GE} = 15 V	-	2.00	-	
Collector to enfitter saturation voltage	V _{CE(on)}	I _C = 6.0 A, T _J = 150 °C	See fig. 2, 5	-	1.60	-	
Gate threshold voltage	V _{GE(th)}	V V I 050		3.0	-	6.0	
Temperature coeff. of threshold voltage	$\Delta V_{GE(th)}/\Delta T_{J}$	$V_{CE} = V_{GE}, I_C = 250 \mu A$		-	- 13	-	mV/°C
Forward transconductance	9 _{fe} (2)	V _{CE} = 100 V, I _C = 12 A		3.0	6.0	-	S
Zero gate voltage collector current	I _{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = 600 \text{ V}$		-	-	250	μA
		V _{GE} = 0 V, V _{CE} = 600 V, T _J = 150 °C		-	-	2500	
Diode forward voltage drop	V _{FM}	I _C = 12 A	Coofie 10	-	1.4	1.7	V
		I _C = 12 A, T _J = 150 °C	See fig. 13	-	1.3	1.6	V
Gate to emitter leakage current	I _{GES}	V _{GE} = ± 20 V		-	-	± 100	nA

Notes

(1) Pulse width \leq 80 µs, duty factor \leq 0.1 %

⁽²⁾ Pulse width 5.0 µs; single shot





PARAMETER	SYMBOL	1	TEST CONDI	TIONS	MIN.	TYP.	MAX.	UNITS
Total gate charge (turn-on)	Qg	I _C = 6 A		-	61	91		
Gate to emitter charge (turn-on)	Q _{ge}	V _{CC} = 400 V			-	7.4	11	nC
Gate to collector charge (turn-on)	Q _{gc}	See fig. 8			-	27	40	
Turn-on delay time	t _{d(on)}				-	55	-	
Rise time	t _r	$T_J = 25 ^{\circ}C$	9			24	-	1
Turn-off delay time	t _{d(off)}	$I_C = 6.0 \text{ A, V}$			-	107	160	ns
Fall time	t _f	V _{GE} = 15 V, I	~	l" and diada	-	92	140	1
Turn-on switching loss	E _{on}	Energy losses include "tail" and diode reverse recovery See fig. 9, 10, 18			-	0.28	-	mJ
Turn-off switching loss	E _{off}				-	0.10	-	
Total switching loss	E _{ts}				-	0.39	0.50	1
Short circuit withstand time	t _{SC}	$V_{CC} = 360 \text{ V}, T_{J} = 125 \text{ °C}$ $V_{GE} = 15 \text{ V}, R_{G} = 23 \Omega, V_{CPK} < 500 \text{ V}$		10	-	-	μs	
Turn-on delay time	t _{d(on)}	T _J = 150 °C I _C = 6.0 A, V _{CC} = 480 V			-	54	-	
Rise time	t _r				-	24	-	ns
Turn-off delay time	t _{d(off)}	V_{GE} = 15 V, R_{G} = 23 Ω Energy losses include "tail" and diode reverse recovery See fig. 10, 11, 18		-	161	-		
Fall time	t _f			-	244	-	1	
Total switching loss	E _{ts}			-	0.60	-	mJ	
Input capacitance	C _{ies}	$V_{GE} = 0 V$			-	740	-	
Output capacitance	C _{oes}			See fig. 7	-	100	-	pF
Reverse transfer capacitance	C _{res}				-	9.3	-	
Diede reverse receiver time		$T_J = 25 ^{\circ}\text{C}$ $T_J = 125 ^{\circ}\text{C}$ See fig. 14	O f- 14		-	42	60	
Diode reverse recovery time	t _{rr}			-	80	120	ns	
Diode peak reverse recovery		$T_{J} = 25 ^{\circ}\text{C}$ $T_{J} = 125 ^{\circ}\text{C}$ See fig. 15	I _F = 12 A V _B = 200 V	-	3.5	6.0	۸	
current	I _{rr}			-	5.6	10	A	
Diada rayaraa raaayany aharaa	0	$T_{J} = 25 ^{\circ}\text{C}$ $T_{J} = 125 ^{\circ}\text{C}$ See fig. 16	V _R = 200 V dl/dt = 200 A/μs	-	80	180	nC	
Diode reverse recovery charge	Q _{rr}			-	220	600	110	
Diode peak rate of fall of recovery	dl/dt	T _J = 25 °C		-	180	-	A/µs	
during t _b	dI _{(rec)M} /dt	$T_{J} = 125 ^{\circ}\text{C}$ See fig. 17			-	120		-

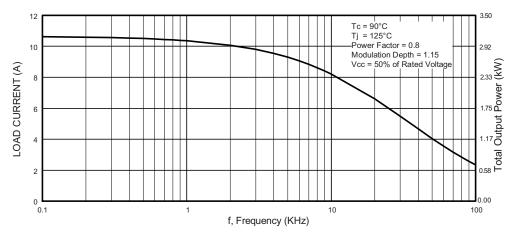


Fig. 1 - Typical Load Current vs. Frequency (Load Current = I_{RMS} of Fundamental)

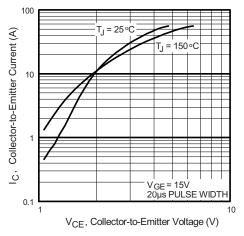


Fig. 2 - Typical Output Characteristics

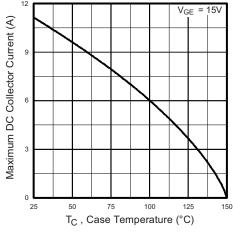


Fig. 4 - Maximum Collector Current vs. Case Temperature

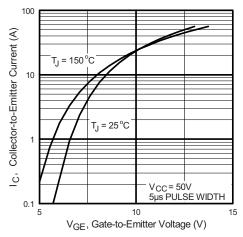


Fig. 3 - Typical Transfer Characteristics

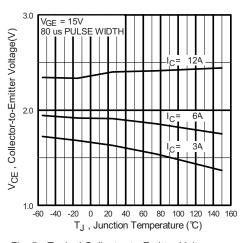


Fig. 5 - Typical Collector to Emitter Voltage vs. Junction Temperature



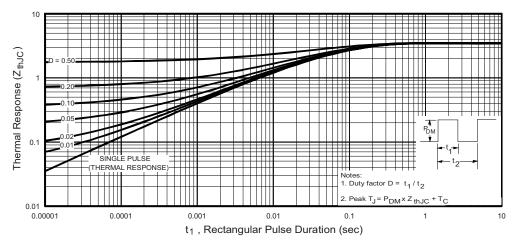


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction to Case

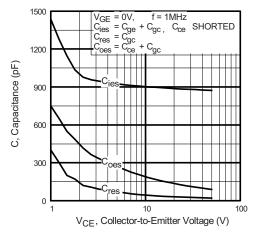


Fig. 7 - Typical Capacitance vs. Collector to Emitter Voltage

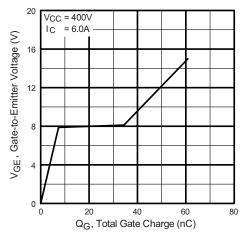


Fig. 8 - Typical Gate Charge vs. Gate to Emitter Voltage

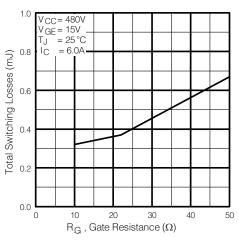


Fig. 9 - Typical Switching Losses vs. Gate Resistance

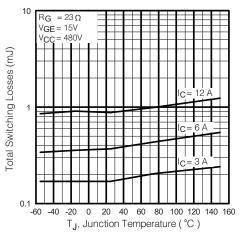


Fig. 10 - Typical Switching Losses vs. Junction Temperature



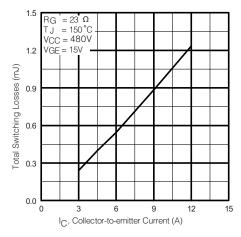


Fig. 11 - Typical Switching Losses vs. Collector to Emitter Current

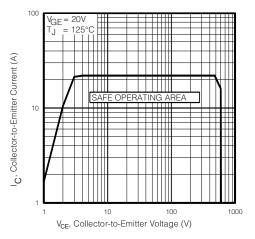


Fig. 12 - Turn-Off SOA

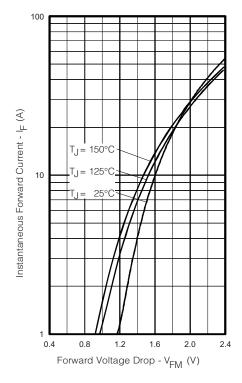


Fig. 13 - Maximum Forward Voltage Drop vs. Instantaneous Forward Current



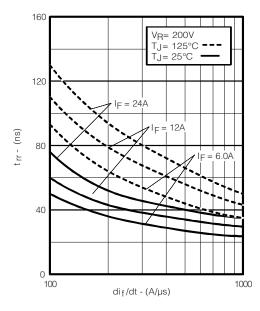


Fig. 14 - Typical Reverse Recovery Time vs. dI_F/dt

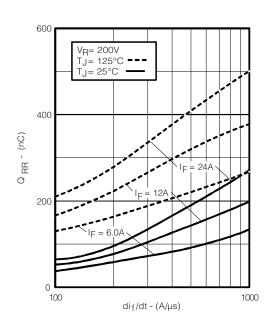


Fig. 16 - Typical Stored Charge vs. dl_F/dt

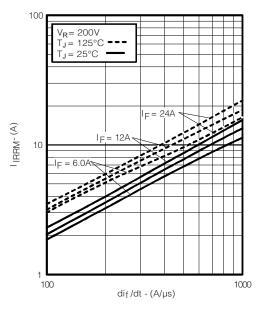


Fig. 15 - Typical Recovery Current vs. dI_F/dt

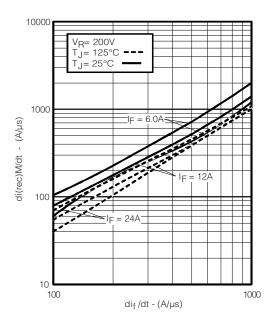


Fig. 17 - Typical dl_{(rec)M}/dt vs dl_F/dt



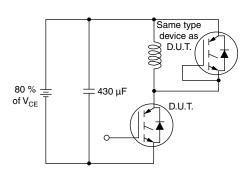


Fig. 18a - Test Circuit for Measurements of I_{LM} , E_{on} , $E_{off(diode)}$, t_{rr} , Q_{rr} , I_{rr} , $t_{d(on)}$, t_r , $t_{d(off)}$, t_f

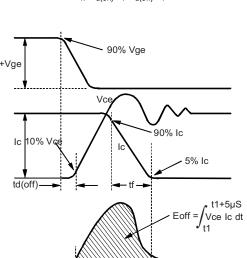


Fig. 18b - Test Waveforms for Circuit of Fig. 18a, Defining $E_{\text{off}},\,t_{\text{d(off)}},\,t_{\text{f}}$

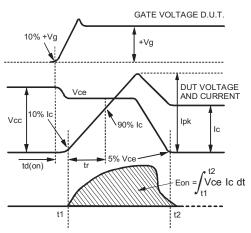


Fig. 18c - Test Waveforms for Circuit of Fig. 18a, Defining E_{on} , $t_{d(on)}$, t_r

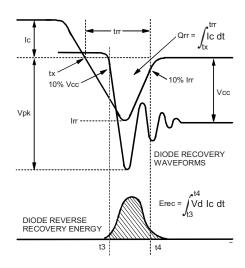


Fig. 18d - Test Waveforms for Circuit of Fig. 18a, Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

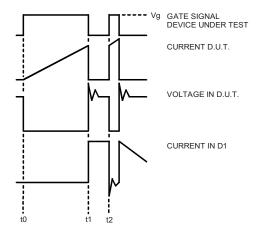
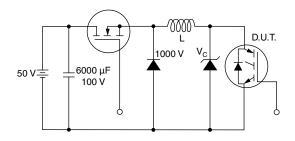


Fig. 18e - Macro Waveforms for Figure 18a's Test Circuit





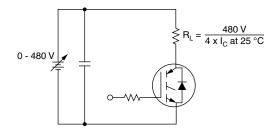
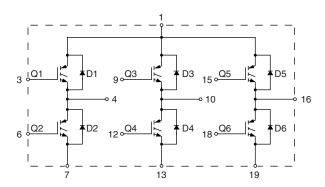


Fig. 19 - Clamped Inductive Load Test Circuit

Fig. 20 - Pulsed Collector Current Test Circuit

CIRCUIT CONFIGURATION

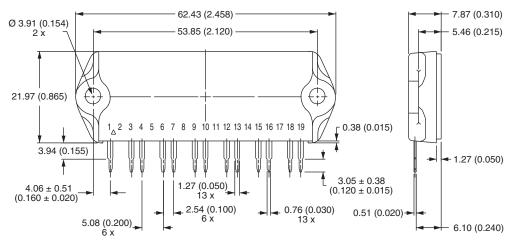


LINKS TO RELATED DOCUMENTS				
Dimensions	www.vishay.com/doc?95066			



IMS-2 (SIP)

DIMENSIONS in millimeters (inches)



IMS-2 Package Outline (13 Pins)

Notes

- $^{(1)}$ Tolerance uless otherwise specified \pm 0.254 mm (0.010")
- (2) Controlling dimension: inch
- (3) Terminal numbers are shown for reference only

Document Number: 95066 Revision: 30-Jul-07



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